Application/Control No. Applicant(s)/Patent Under Reexamination 10/663,774 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2871 **Dung Nguyen U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,256,077 07-2001 Baek, Bum-Ki 349/43 Α US-6,461,899 10-2002 Kitakado et al. 438/149 В С US-US-D US-Ε US-F US-G US-Н USı US-US-Κ US-US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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